

U.S. PATENT DOCUMENTS

														
	FORM F (Rev. 2		49 U.S. PATEN						ATTY. DOCKET N DON01 P-889	0.	SERIAL NO. 09/817,874	3		
			FORM <i>A</i> ATEMI	_				DEC	1 8 2000 SS	APPLICANT(S) Chad D. Quist et al.		<u>```</u>		
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17	İ	6	0	0	0	8	2	3	12/14/1999	Desmond et al.	362	494	i	
1	1	5	9	3	8	3	2	1	08/17/1999	Bos et al.	362	494		
	†	5	9	2	9	7	8	6	07/27/1999	Schofield et al.	340	903		
		5	8	7	7	8	9	7	03/02/1999	Schofield et al.	359	604		
	†	5	8	2	0	2	4	5	10/13/1998	Desmond et al.	362	83.1		
		5	8	1	3	7	4	5	09/29/1998	Fant, Jr. et al.	362	83.1	 	
		5	8	1	2	3	2	1	09/22/1998	Schierbeek et al.	359	601		
	T	5	7	9	8	6	8	8	08/25/1998	Schofield	340	438		
	1	5	7	6	0	9	6	2	06/02/1998	Schofield et al.	359	604	<u> </u>	
	1	5	7	0	8	4	1	0	01/13/1998	Blank et al.	340	438		
	1	5	6	7	3	9	9	4	10/07/1997	Fant, Jr. et al.	362	831		
₹. 1		5	6	7	1	9	9	6	09/30/1997	Bos et al.	362	83.1		

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1	EP 0	6	1	5	8	8	2	A2	09/21/1994	EPC				
1/		2	2	9	7	6	3	2A	08/07/1996	Great Britain				
•		2	2	9	2	8	5	7A	03/06/1996	Great Britain				
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,					1	Sheet 2 of 5	
	1 PTO-1449 U.S. DEPARTMENT OF COMMERCE v. 2-32) PATENT AND TRADEMARK OFFICE	PE	ATTY. DOCKET NO DON01 P-889		SERIAL NO. 19/817,874		
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT	8 2001 SS	APPLICANT(S) Chad D. Quist et al.		è	\(\frac{\kappa_{\chi}}{\chi_{\chi}}\)	\$.
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4.7		5	6	6	9	6	9	8	09/23/1997	Veldman et al.	362	83.1	
)		5	6	4	9	7	5	6	07/22/1997	Adams et al.	362	83.1	
		5	6	1	5	8	5	7	04/01/1997	Hook	248	549	
		5	5	7	6	6	8	7	11/19/1996	Blank et al.	340	438	1
		5	5	7	2	3	5	4	11/05/1996	Desmond et al.	359	265	· · · · · · · · · · · · · · · · · · ·
		5	5	3	0	2	4	0	06/25/1996	Larson et al.	250	214	
		5	5	2	1	7	6	0	05/28/1996	De Young et al.	359	601	<u> </u>
	l	5	4	8	7	5	2	2	01/30/1996	Hook	248	549	
		5	3	2	7	2	8	8	07/05/1994	Wellington et al.	359	606	<u> </u>
		5	2	8	5	0	6	0	02/08/1994	Larson et al.	250	214	<u>† </u>
		5	2	5	3	1	0	9	10/12/1993	O'Farrell et al.	359	604	
4 ,4		5	1	7	8	4	4	8	01/12/1993	Adams et al.	362	83.1	

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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Rev. 2-32) PATENT AND TRADEMARK OF HISE	ATTY. DOCKET NO. DON01 P-885	SERIAL NO. 09/817,874
INFORMATION DISCLOSURE STATEMENT BY APPLICANT DEC 1 8 2001 2	APPLICANT(S) Chad D. Quist	
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#.4	5	1	0	0	0	9	5	03/31/1992	Haan et al.	248	549	İ
	4	9	4	8	2	4	2	08/14/1990	Desmond et al.	350	637	
	4	9	3	6	5	3	3	06/26/1990	Adams et al.	248	222.1	
	4	8	8	2	5	6	5	11/21/1989	Gallmeyer	340	461	
	4	8	2	6	2	8	9	05/02/1989	Vandenbrink et al.	350	281	
	4	8	0	7	0	9	6	02/21/1989	Skogler et al.	362	142	i
	4	7	. 3	3	3	3	6	03/22/1988	Skogler et al.	362	142	
	4	6	4	6	2	1	0	02/24/1987	Skogler et al.	362	142	
	4	5	8	8	2	6	7	05/13/1986	Pastore	350	600	
	4	4	4	3	0	5	7	04/17/1984	Bauer et al.	350	281	<u> </u>
W	4	4	3	6	3	7	1	05/13/1984	Wood et al.	350	281	
1.2	4	4	3	5	0	4	2	05/06/1984	Wood et al.	350	281	

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772	3	9	7	8	1	9	Το	08/31/1976	Kurz, Jr. et al.	264	242	
~ \	3	8	7	0	4	0	4	03/11/1975	Wilson et al.	350	281	
	3	5	4	3	0	1	8	11/24/1970	E. L. Barcus et al.	240	4.2	
	3	4	6	7	4	6	5	09/16/1969	A. J. Van Noord	350	281	
	3	1	5	2	2	1	6	10/06/1964	M. L. Woodward	88	77	
	3	10	7	1 3	1 4	1 3	0	01/20/1063	M. I. Woodward et al.	88	77	1

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R. N. Arthur et al.

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Skogler et al.

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FORM PTO-	-1449 U.S. DEPARTMENT OF COMMERCE	
(Rev. 2-32	-1449 U.S. DEPARTMENT OF COMMERCE) PATENT AND TRADEMARK OFFICE	
`	(A) P	E.
	INFORMATION DISCLOSURE	- .3
	STATEMENT BY APPLICANT	Č

	FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Rev. 2-32) PATENT AND TRADEMARK OFFICE										О.	SERIAL NO. 09/817,874		
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT									APPLICANT(S) Chad D. Quist		à	~ Pr	
	(Use several sheets if necessary) DEC 18 2001 CA											GROUP 3632	FILING SHEET	
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द्वार		5	8	7	8	3	5	3	03/02/1999	ul Azam et al.	455	550	T T	
		5	5	6	6	2	2	4	10/15/1996	ul Azam et al.	379	58		
		6	1	7	5	1	6	4	01/16/2001	O'Farrell et al.	307	10.1		
		6	0	4	2	2	5	3	03/28/2000	Fant, Jr. et al.	362	494		
		6	1	8	3	1	1	9	02/06/2001	Desmond et al.	362	494		
Ī		6	1	2	4	8	8	6	09/26/2000	DeLine et al.	348	148		Į
		6	2	4	3	0	0	3	06/05/2001	DeLine et al.	340	425.5		
		6	2	2	2	4	4	7	04/24/2001	Schofield et al.	340	461		ĺ
		6	1	9	8	4	0	9	03/26/2001	Schofield et al.	340	903		ĺ
		6	1	7	2	6	1	3	01/09/2001	DeLine et al.	340	815.4		
		6	1	2	4	6	4	7	09/26/2000	Marcus et al.	307	10.1		
		6	1	5	8	6	5	5	12/12/2000	DeVries, Jr. et al.	235	380		
		6	2	2	2	4	6	0	04/24/2001	DeLine et al.	340	815.4		
	İ	5	4	0	6	4	1	4	04/11/1995	O'Farrell et al.	359	604		
		6	0	0	5	5	3	8	12/21/1999	Hoekstra	345	47		
		5	7	9	8	5	7	5	08/25/1998	O'Farrell et al.	307	10.1		1
		5	5	3	0	2	4	0	06/25/1996	Larson et al.	250	214	· .	
*		5	9	7	1	5	5	2	10/26/1999	O'Farrell et al.	359	871		
₹. ८		5	8	2	0	2	4	5	10/13/1998	Desmond et al.	362	83.1		

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#-7		5	8	1	8	0	3	47	10/21/1983	Japan			Abstract	

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